CBTL06DP213

Third generation high-performance DisplayPort multiplexer

Rev. 4 — 23 March 2017

Product data sheet

1. General description

CBTL06DP213 is an NXP third generation high-performance multi-channel multiplexer, meant for DisplayPort (DP) v1.3 or Embedded DisplayPort applications operating at data rate of 1.62 Gbit/s, 2.7 Gbit/s, 5.4 Gbit/s or 8.1 Gbit/s. It is designed using NXP proprietary high-bandwidth pass-gate technology and it can be used for 1 : 2 switching or 2 : 1 multiplexing of four high-speed differential AC-coupled DP channels. Further, it is capable of switching/multiplexing of Hot Plug Detect (HPD) signal as well as Auxiliary (AUX) and Display Data Channel (DDC) signals. In order to support GPUs/CPUs that have dedicated AUX and DDC I/Os, CBTL06DP213 provides an additional level of multiplexing of AUX and DDC signals delivering true flexibility and choice.

A typical application of CBTL06DP213 is on motherboards where one of two GPU DisplayPort sources needs to be selected to connect to a DisplayPort sink device or connector. A controller chip selects which path to use by setting a select signal HIGH or LOW. Due to the bidirectional nature of the signal paths, CBTL06DP213 can also be used in the reverse topology, for example, to connect one display source device to one of two display sink devices or connectors.

2. Features and benefits

- 1:2 switching or 2:1 multiplexing of DisplayPort (v1.3 8.1 Gbit/s) signals
 - 4 high-speed differential channels with 2 : 1 multiplexing/switching for DisplayPort main link signals
 - ◆ 1 channel with 4 : 1 multiplexing/switching for AUX or DDC signals
 - ◆ 1 channel with 2 : 1 multiplexing/switching for HPD signal
- High-bandwidth analog pass-gate technology
- R_{on} on DP high-speed channels: 14 Ω
- Low insertion loss:
 - ◆ -0.9 dB at 100 MHz
 - ◆ -1.3 dB at 2.7 GHz
 - ◆ -1.7 dB at 4 GHz
 - ◆ -3 dB at 11.1 GHz
- Low crosstalk: -35 dB at 2.7 GHz
- Low off-state isolation: -30 dB at 2.7 GHz, -25 dB at 4 GHz
- Low return loss:
 - ◆ -20.3 dB at 100 MHz
 - ◆ -16.7 dB at 1.35 GHz
 - ◆ -12.9 dB at 2.7 GHz
 - ◆ -12 dB at 4 GHz



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- Very low intra-pair skew (5 ps typical)
- Very low inter-pair skew (< 80 ps)</p>
- Switch/multiplexer position select CMOS input
- DDC and AUX ports tolerant to being pulled to +5 V via 2.2 kΩ resistor
 - Supports HDMI/DVI incorrect dongle connection
- Single 3.3 V power supply
- Operation current of 2 mA typical,
- ESD 2 kV HBM, 500 V CDM
- Available in 5 mm × 5 mm, 0.5 mm ball pitch TFBGA48 package

3. Applications

- Motherboard applications requiring DisplayPort and PCI Express switching/multiplexing
- Docking stations
- Notebook computers
- Chip sets requiring flexible allocation of PCI Express or DisplayPort I/O pins to board connectors

4. Ordering information

Table 1. Ordering information

| Type number | | | | | |
|---------------|-------|----------------------------------|---------|---|----------|
| | mark | | Name | Description | Version |
| CBTL06DP213EE | 6D213 | Pb-free (SnAgCu solder compound) | TFBGA48 | plastic thin fine-pitch ball grid array package; 48 balls; body $5 \times 5 \times 0.8 \text{ mm}^{\boxed{11}}$ | SOT918-1 |

^[1] Total height including solder balls after printed circuit board mounting = 1.15 mm maximum.

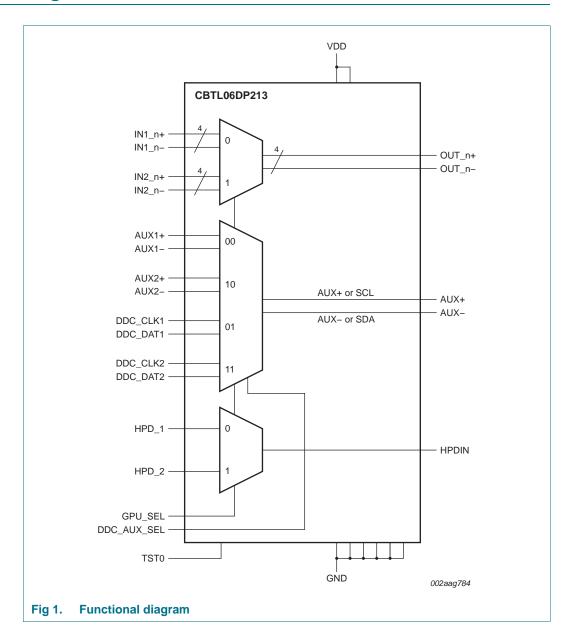
For more information on product marking, refer to www.nxp.com/products/related/package-markings.html.

4.1 Ordering options

Table 2. Ordering options

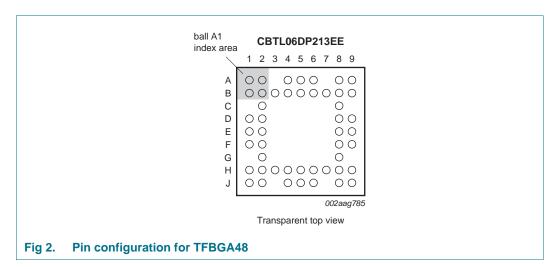
| Type number | Orderable part number | Package | g | Minimum order quantity | Temperature |
|---------------|-----------------------|---------|-----------------------------------|------------------------------|--|
| CBTL06DP213EE | CBTL06DP213EE,118 | TFBGA48 | Reel 13" Q1/T1 *standard mark SMD | 3000 | $T_{amb} = -40 ^{\circ}\text{C} \text{ to } +105 ^{\circ}\text{C}$ |

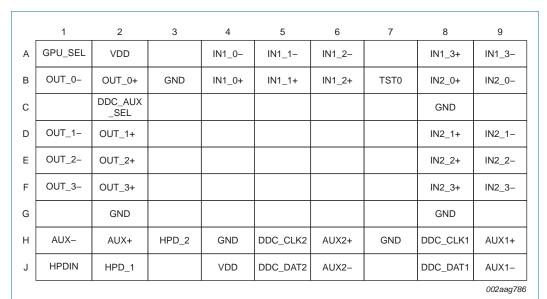
5. Functional diagram



6. Pinning information

6.1 Pinning





Transparent top view

Fig 3. Ball mapping

6.2 Pin description

Table 3. Pin description

| Symbol | Ball | Туре | Description |
|-------------|------|----------------------------------|---|
| GPU_SEL | A1 | 3.3 V CMOS single-ended input | Selects between two multiplexer/switch paths. When HIGH, path 2 left-side is connected to its corresponding right-side I/O. When LOW, path 1 left-side is connected to its corresponding right-side I/O. |
| DDC_AUX_SEL | C2 | 3.3 V CMOS single-ended input | Selects between DDC and AUX paths. When HIGH, the CLK and DAT I/Os are connected to their respective DDCOUT terminals. When LOW, the AUX+ and AUX- I/Os are connected to their respective DDCOUT terminals. |
| TST0 | B7 | 3.3 V CMOS single-ended input | Test pin for NXP use only. Should be tied to V_{DD} in the application use cases. |
| IN1_0+ | B4 | differential I/O | Four high-speed differential pairs for DisplayPort signals, path 1, |
| IN1_0- | A4 | differential I/O | left-side. |
| IN1_1+ | B5 | differential I/O | |
| IN1_1- | A5 | differential I/O | |
| IN1_2+ | B6 | differential I/O | |
| IN1_2- | A6 | differential I/O | |
| IN1_3+ | A8 | differential I/O | |
| IN1_3- | A9 | differential I/O | |
| IN2_0+ | B8 | differential I/O | Four high-speed differential pairs for DisplayPort signals, path 2, |
| IN2_0- | B9 | differential I/O | left-side. |
| IN2_1+ | D8 | differential I/O | |
| IN2_1- | D9 | differential I/O | |
| IN2_2+ | E8 | differential I/O | |
| IN2_2- | E9 | differential I/O | |
| IN2_3+ | F8 | differential I/O | |
| IN2_3- | F9 | differential I/O | |
| OUT_0+ | B2 | differential I/O | Four high-speed differential pairs for DisplayPort signals, |
| OUT_0- | B1 | differential I/O | right-side. |
| OUT_1+ | D2 | differential I/O | |
| OUT_1- | D1 | differential I/O | |
| OUT_2+ | E2 | differential I/O | |
| OUT_2- | E1 | differential I/O | |
| OUT_3+ | F2 | differential I/O | |
| OUT_3- | F1 | differential I/O | |
| AUX1+ | H9 | differential I/O | High-speed differential pair for AUX signals, path 1, left-side. |
| AUX1- | J9 | differential I/O | |
| AUX2+ | H6 | differential I/O | High-speed differential pair for AUX signals, path 2, left-side. |
| AUX2- | J6 | differential I/O | |
| DDC_CLK1 | H8 | differential I/O | Pair of single-ended terminals for DDC clock and data signals, |
| DDC_DAT1 | J8 | differential I/O | path 1, left-side. |

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Table 3. Pin description ...continued

| Symbol | Ball | Туре | Description |
|----------|------------------------------|------------------|---|
| DDC_CLK2 | H5 | differential I/O | Pair of single-ended terminals for DDC clock and data signals, |
| DDC_DAT2 | J5 | differential I/O | path 2, left-side. |
| AUX+ | H2 | differential I/O | High-speed differential pair for AUX or single-ended DDC signals, |
| AUX- | H1 | differential I/O | right-side. |
| HPD_1 | J2 | single-ended I/O | Single ended channel for the HPD signal, path 1, left-side. |
| HPD_2 | H3 | single-ended I/O | Single ended channel for the HPD signal, path 2, left-side. |
| HPDIN | J1 | single-ended I/O | Single ended channel for the HPD signal, right-side. |
| VDD | A2, J4 | power supply | 3.3 V power supply. |
| GND | B3, C8, G2, G8, H4, H7 | ground | Ground. |

7. Functional description

Refer to Figure 1 "Functional diagram".

The CBTL06DP213 uses a 3.3 V power supply. All main signal paths are implemented using high-bandwidth pass-gate technology and are bidirectional. No clock or reset signal is needed for the multiplexer to function.

The switch position for the main channels is selected using the select signal GPU_SEL. Additionally, the signal DDC_AUX_SEL selects between AUX and DDC positions for the DDC / AUX channel. The detailed operation is described in Section 7.1.

7.1 Multiplexer/switch select functions

The internal multiplexer switch position is controlled by two logic inputs GPU_SEL and DDC_AUX_SEL as described below.

Table 4. Multiplexer/switch select control for INn and OUTn channels

| GPU_SEL | IN1_n | IN2_n |
|---------|----------------------------|----------------------------|
| 0 | active; connected to OUT_n | high-impedance |
| 1 | high-impedance | active; connected to OUT_n |

Table 5. Multiplexer/switch select control for HPD channel

| GPU_SEL | HPD_1 | HPD_2 |
|---------|----------------------------|----------------------------|
| 0 | active; connected to HPDIN | high-impedance |
| 1 | high-impedance | active; connected to HPDIN |

Table 6. Multiplexer/switch select control for DDC and AUX channels

| DDC_AUX_SEL | GPU_SEL | AUX1 | AUX2 | DDC_CLK1, DDC_DAT1 | DDC_CLK2, DDC_DAT2 |
|-------------|---------|--------------------------|-----------------------------|-----------------------------|-----------------------------|
| 0 | 0 | active; connected to AUX | high-impedance | high-impedance | high-impedance |
| 0 | 1 | high-impedance | active; connected to AUX | high-impedance | high-impedance |
| 1 | 0 | high-impedance | high-impedance | active; connected to AUX | high-impedance |
| 1 | 1 | high-impedance | high-impedance | high-impedance | active; connected to AUX |

8. Limiting values

Table 7. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|-------------------|-------------------------|------------|-----|------|------|------|
| V_{DD} | supply voltage | | | -0.3 | +5 | V |
| T _{case} | case temperature | | | -40 | +105 | °C |
| V_{ESD} | electrostatic discharge | HBM | [1] | - | 2000 | V |
| | voltage | CDM | [2] | - | 500 | V |

^[1] Human Body Model: ANSI/EOS/ESD-S5.1-1994, standard for ESD sensitivity testing, Human Body Model - Component level; Electrostatic Discharge Association, Rome, NY, USA.

9. Recommended operating conditions

Table 8. Recommended operating conditions

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|------------------|---------------------|-----------------------|-----|------|-----|-----------------------|------|
| V_{DD} | supply voltage | | | 3.0 | 3.3 | 3.6 | V |
| VI | input voltage | CMOS inputs | | -0.3 | - | V _{DD} + 0.3 | V |
| | | HPD inputs | [1] | -0.3 | - | V _{DD} + 0.3 | V |
| | | DDC/AUX inputs | [2] | -0.3 | - | V _{DD} + 0.3 | V |
| | | other inputs | | -0.3 | - | +2.6 | V |
| T _{amb} | ambient temperature | operating in free air | | -40 | - | +105 | °C |

^[1] HPD input is tolerant to 5 V input, provided a 1 $k\Omega$ series resistor between the voltage source and the pin is placed in series.

^[2] Charged Device Model: ANSI/EOS/ESD-S5.3-1-1999, standard for ESD sensitivity testing, Charged Device Model - Component level; Electrostatic Discharge Association, Rome, NY, USA.

^[2] DDC/AUX inputs are tolerant to 5 V input, provided a 2.2 kΩ series resistor between the voltage source and the pin is placed in series.

10. Characteristics

10.1 General characteristics

Table 9. General characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|----------------------|--|-----|-----|-----|------|
| I _{DD} | supply current | operating mode | - | 2 | 3 | mA |
| P _{cons} | power consumption | operating mode | - | - | 10 | mW |
| t _{startup} | start-up time | supply voltage valid to channel specified operating characteristics | - | - | 5 | ms |
| t _{rcfg} | reconfiguration time | GPU_SEL or DDC_AUX_SEL state change to channel specified operating characteristics | - | - | 1 | μS |

10.2 DisplayPort channel characteristics

Table 10. DisplayPort channel characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|---------------------------------|--|------|-------|------|------|
| VI | input voltage | | -0.3 | - | +2.6 | V |
| V _{IC} | common-mode input voltage | | 0 | - | 2.0 | V |
| V_{ID} | differential input voltage | peak-to-peak | - | - | +1.2 | V |
| R _{on} | ON-state resistance | $V_{DD} = 3.3 \text{ V}; V_{I} = 2 \text{ V}; I_{I} = 20 \text{ mA}$ | - | 14 | - | Ω |
| DDIL | differential insertion loss | channel is ON; f ≤ 100 MHz | - | -0.9 | - | dB |
| | | channel is ON; f = 2.7 GHz1.3 | - | dB | | |
| | | channel is ON; f = 4 GHz | - | -1.7 | - | dB |
| | | channel is OFF; f = 2.7 GHz | - | -30 | - | dB |
| | | channel is OFF; f = 4 GHz | - | -25 | - | dB |
| DDRL | differential return loss | f = 100 MHz | - | -20.3 | - | dB |
| | | f = 1.35 GHz | - | -16.7 | - | dB |
| | | f = 2.7 GHz | - | -12.9 | - | dB |
| | | f = 4 GHz | - | -12.0 | - | dB |
| DDNEXT | differential near-end crosstalk | adjacent channels are ON | | ' | | |
| | | f = 100 MHz | - | -65 | | dB |
| | | f = 2.7 GHz | - | -35 | - | dB |
| | | f = 4 GHz | - | -23 | - | dB |
| В | bandwidth | -3.0 dB intercept | - | 11.1 | - | GHz |
| t _{PD} | propagation delay | from left-side port to right-side port or vice versa | - | 80 | - | ps |
| t _{sk(dif)} | differential skew time | intra-pair | - | 5 | - | ps |
| t _{sk} | skew time | inter-pair | - | - | 80 | ps |

10.3 AUX and DDC ports

Table 11. AUX and DDC port characteristics

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|-----------------|----------------------------|--|------------|------|-----|----------------|------|
| VI | input voltage | | | -0.3 | - | $V_{DD} + 0.3$ | V |
| Vo | output voltage | no load | | - | VI | $V_{DD} + 0.3$ | V |
| V _{IC} | common-mode input voltage | AUX | | 0 | - | 2.0 | V |
| V_{ID} | differential input voltage | AUX | | - | - | +1.4 | V |
| t _{PD} | propagation delay | from left-side port to right-side port or vice versa | <u>[1]</u> | - | 80 | - | ps |

^[1] Time from DDC/AUX input changing state to AUX output changing state. Includes DDC/AUX rise/fall time.

10.4 HPDIN input, HPD_x outputs

Table 12. HPD input and output characteristics

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|-----------------|-------------------|-----------------------------------|-----|------|-----|----------------|------|
| V_{I} | input voltage | | | -0.3 | - | $V_{DD} + 0.3$ | V |
| Vo | output voltage | no load | | - | VI | $V_{DD} + 0.3$ | V |
| t _{PD} | propagation delay | from HPDIN to HPD_x or vice versa | [1] | - | 80 | - | ps |

^[1] Time from HPDIN changing state to HPD_x changing state. Includes HPD rise/fall time.

10.5 GPU_SEL and DDC_AUX_SEL inputs

Table 13. GPU_SEL and DDC_AUX_SEL input characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------|--------------------------|---|-----|-----|-----|------|
| V _{IH} | HIGH-level input voltage | | 2.0 | - | - | V |
| V_{IL} | LOW-level input voltage | | - | - | 0.8 | V |
| I _{LI} | input leakage current | $V_{DD} = 3.6 \text{ V}; \ 0.3 \text{ V} \le V_{I} \le 3.9 \text{ V}$ | - | - | 10 | μΑ |

11. Package outline

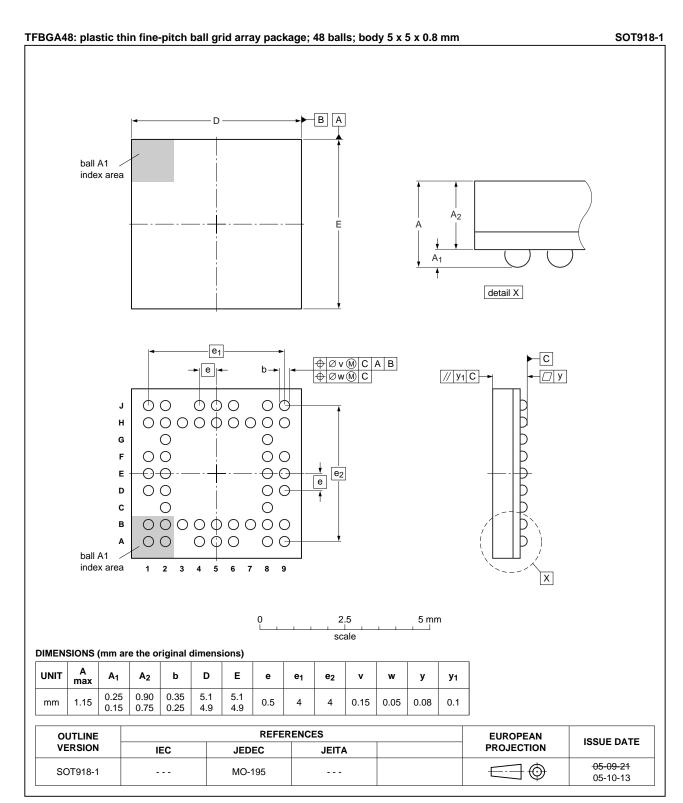


Fig 4. Package outline TFBGA48 (SOT918-1)

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12. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365* "Surface mount reflow soldering description".

12.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

12.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- · Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- · Board specifications, including the board finish, solder masks and vias
- · Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

12.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

12.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 5</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 14 and 15

Table 14. SnPb eutectic process (from J-STD-020D)

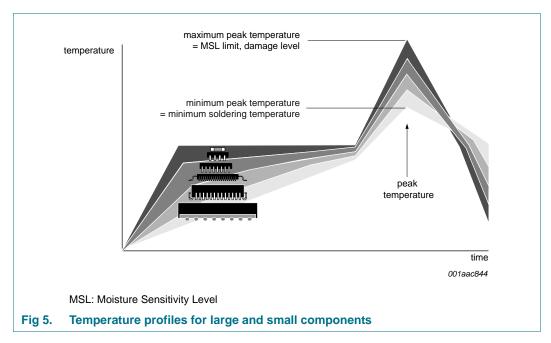
| Package thickness (mm) | Package reflow temperature (°C) Volume (mm³) | | |
|------------------------|---|-------|--|
| | | | |
| | < 350 | ≥ 350 | |
| < 2.5 | 235 | 220 | |
| ≥ 2.5 | 220 | 220 | |

Table 15. Lead-free process (from J-STD-020D)

| Package thickness (mm) | Package reflow temperature (°C) Volume (mm³) | | | |
|------------------------|---|-------------|--------|--|
| | | | | |
| | < 350 | 350 to 2000 | > 2000 | |
| < 1.6 | 260 | 260 | 260 | |
| 1.6 to 2.5 | 260 | 250 | 245 | |
| > 2.5 | 250 | 245 | 245 | |

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 5.



For further information on temperature profiles, refer to Application Note *AN10365* "Surface mount reflow soldering description".

13. Abbreviations

Table 16. Abbreviations

| Acronym | Description |
|---------|---|
| AUX | Auxiliary channel (in DisplayPort definition) |
| CDM | Charged-Device Model |
| CMOS | Complementary Metal-Oxide Semiconductor |
| CPU | Central Processing Unit |
| DP | DisplayPort |
| DVI | Digital Video Interface |
| ESD | ElectroStatic Discharge |
| GPU | Graphics Processor Unit |
| НВМ | Human Body Model |
| HDMI | High-Definition Multimedia Interface |
| I/O | Input/Output |
| PCI | Peripheral Component Interconnect |

14. Revision history

Table 17. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes | | |
|-------------------|---|--------------------|---------------|-------------------|--|--|
| CBTL06DP213 v.4 | 20170323 | Product data sheet | - | CBTL06DP213 v.3.1 | | |
| Modifications: | Updated to DP v1.3 | | | | | |
| | <u>Table 10 "DisplayPort channel characteristics"</u>: Added f = 4 GHz char data for DDIL, DDRL, and DDNEXT | | | | | |
| CBTL06DP213 v.3.1 | 20150316 | Product data sheet | - | CBTL06DP213 v.3 | | |
| Modifications: | Figure 1 "Functional diagram": pin name changed from "XSD" to "TST0" | | | | | |
| | Figure 3 "Ball mapping": pin (ball) B7 changed from "XSD" to "TST0" | | | | | |
| CBTL06DP213 v.3 | 20150108 | Product data sheet | - | CBTL06DP213 v.2 | | |
| CBTL06DP213 v.2 | 20120619 | Product data sheet | - | CBTL06DP213 v.1 | | |
| CBTL06DP213 v.1 | 20120213 | Product data sheet | - | - | | |

15. Legal information

15.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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Third generation high-performance DisplayPort multiplexer

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